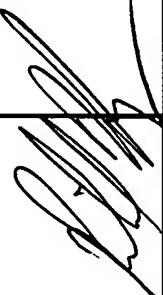
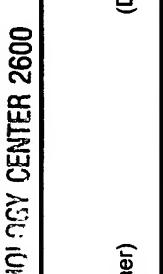
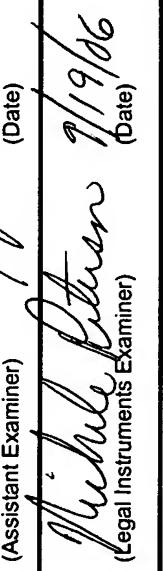


<b>Issue Classification</b>		Application/Control No.	Applicant(s)/Patent under Reexamination		
		10716664	YABU ET AL.		
Examiner		Nguyen, Kevin M	Art Unit 2629		
<b>ORIGINAL</b>					
<b>INTERNATIONAL CLASSIFICATION</b>					
CLASS		SUBCLASS	CLAIMED		NON-CLAIMED
345		75.2	G 0	9 G	3 / 30
			G 0	9 G	1 / 04
			H 0	1 J	29 / 70
<b>CROSS REFERENCE(S)</b>					
SUBCLASS (ONE SUBCLASS PER BLOCK)					
CLASS	315	366			
	313	422			
 Kevin M. Nguyen 9/11/06 (Assistant Examiner)					
 RICHARD HJERPE SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600					
 Michael O'Brien 7/9/06 (Primary Examiner) (Legal Instruments Examiner)					
			<b>Total Claims Allowed:</b> 14		
			O.G. Print Claim(s) 1	O.G. Print Figure 1	